

PMV56XN

µTrenchMOS™ extremely low level FET Rev. 02 — 24 June 2004

Product data

Product profile

1.1 Description

N-channel enhancement mode field-effect transistor in a plastic package using TrenchMOS™ technology.

1.2 Features

- TrenchMOS[™] technology
- Low threshold voltage
- Very fast switching
- Subminiature surface mount package.

1.3 Applications

- Battery management
- High-speed switch
- Low power DC-to-DC converter.

1.4 Quick reference data

- $V_{DS} \le 20 \text{ V}$
- $P_{tot} \le 1.92 \text{ W}$

- $I_D \le 3.76 \text{ A}$
- R_{DSon} \leq 85 m Ω

Pinning information 2.

Pinning - SOT23, simplified outline and symbol

Pin	Description	Simplified outline	Symbol
1	gate (g)		
2	source (s)		d
3	drain (d)	12 Top view	g





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3. Ordering information

Table 2: Ordering information

Type number	Package		
	Name	Description	Version
PMV56XN	SOT23	Plastic surface mounted package; 3 leads	SOT23

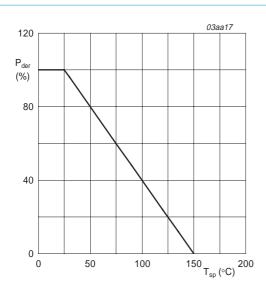
4. Limiting values

Table 3: Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

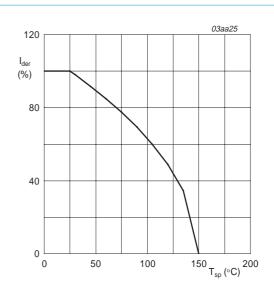
Symbol	Parameter	Conditions	Min	Max	Unit
V_{DS}	drain-source voltage (DC)	25 °C ≤ T _j ≤ 150 °C	-	20	V
V_{GS}	gate-source voltage (DC)		-	±8	V
I_D	drain current (DC)	T_{sp} = 25 °C; V_{GS} = 4.5 V; Figure 2 and 3	-	3.76	Α
		$T_{sp} = 70 ^{\circ}\text{C}; V_{GS} = 4.5 \text{V}; \text{Figure 2}$	-	3	Α
I_{DM}	peak drain current	T_{sp} = 25 °C; pulsed; $t_p \le 10 \mu s$; Figure 3	-	15	Α
P _{tot}	total power dissipation	T _{sp} = 25 °C; Figure 1	-	1.92	W
T_{stg}	storage temperature		-65	+150	°C
Tj	junction temperature		-65	+150	°C
Source-o	drain diode				
I _S	source (diode forward) current (DC)	$T_{sp} = 25 ^{\circ}\text{C}$	-	1.6	Α

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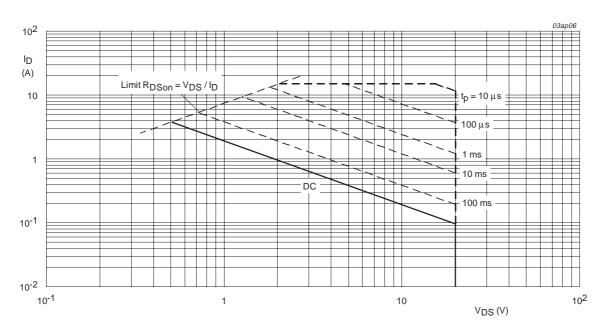
$$P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100\%$$

Fig 1. Normalized total power dissipation as a function of solder point temperature.



$$I_{der} = \frac{I_D}{I_{D(25^{\circ}C)}} \times 100\%$$

Fig 2. Normalized continuous drain current as a function of solder point temperature.



 T_{sp} = 25 °C; I_{DM} is single pulse; V_{GS} = 4.5 V.

Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage.

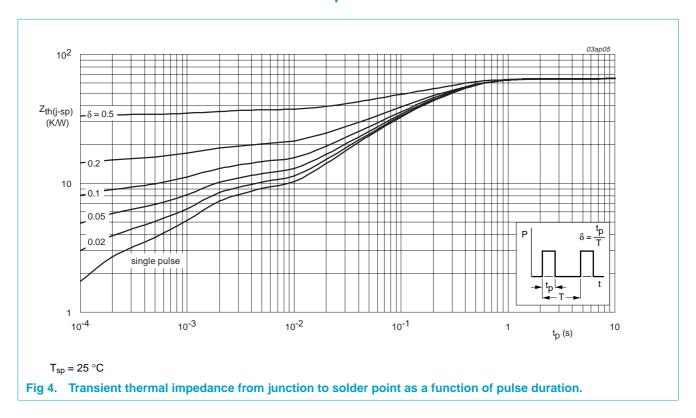
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5. Thermal characteristics

Table 4: Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-sp)}$	thermal resistance from junction to solder point	Figure 4	-	-	65	K/W

5.1 Transient thermal impedance



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6. Characteristics

Table 5: Characteristics

 $T_i = 25 \,^{\circ}C$ unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static ch	aracteristics					
V _{(BR)DSS}	drain-source breakdown voltage	$I_D = 10 \mu A; V_{GS} = 0 V$	20	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$I_D = 1 \text{ mA}$; $V_{DS} = V_{GS}$; Figure 9	0.65	-	-	V
I _{DSS}	drain-source leakage current	$V_{DS} = 20 \text{ V}; V_{GS} = 0 \text{ V}$				
		T _j = 25 °C	-	0.01	1.0	μΑ
		T _j = 55 °C	-	-	10	μΑ
I_{GSS}	gate-source leakage current	$V_{GS} = \pm 8 \text{ V}; V_{DS} = 0 \text{ V}$	-	10	100	nA
R_{DSon}	drain-source on-state resistance	$V_{GS} = 4.5 \text{ V}; I_D = 3.6 \text{ A}; Figure 7 and 8$	-	56	85	$m\Omega$
		$V_{GS} = 2.5 \text{ V}; I_D = 3.1 \text{ A}; Figure 7 and 8$	-	77	115	$m\Omega$
Dynamic	characteristics					
$Q_{g(tot)}$	total gate charge	$V_{DD} = 10 \text{ V}; V_{GS} = 4.5 \text{ V}; I_D = 3.6 \text{ A}; Figure 13$	-	5.4	-	nC
Q_{gs}	gate-source charge			0.65	-	nC
Q_{gd}	gate-drain (Miller) charge		-	1.6	-	nC
C_{iss}	input capacitance	$V_{GS} = 0 \text{ V}; V_{DS} = 10 \text{ V}; f = 1 \text{ MHz}; Figure 11$	-	230	-	pF
C_{oss}	output capacitance		-	125	-	pF
C_{rss}	reverse transfer capacitance		-	80	-	pF
$t_{d(on)}$	turn-on delay time	V_{DD} = 10 V; R_L = 5.5 Ω ; V_{GS} = 4.5 V; R_G = 6 Ω	-	12	-	ns
t _r	rise time		-	23	-	ns
t _{d(off)}	turn-off delay time			50	-	ns
t _f	fall time		-	34	-	ns
Source-o	drain diode					
V_{SD}	source-drain (diode forward) voltage	I _S = 1.6 A; V _{GS} = 0 V; Figure 12	-	8.0	1.2	V

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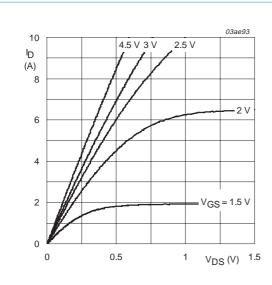


Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values.

 $T_j = 25 \, ^{\circ}C$

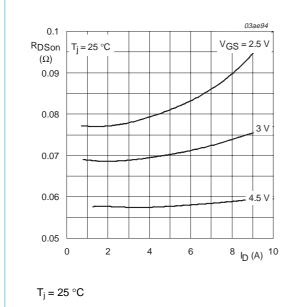
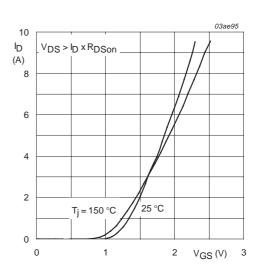
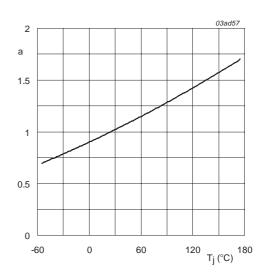


Fig 7. Drain-source on-state resistance as a function of drain current; typical values.



 $T_j = 25$ °C and 150 °C; $V_{DS} > I_D \times R_{DSon}$

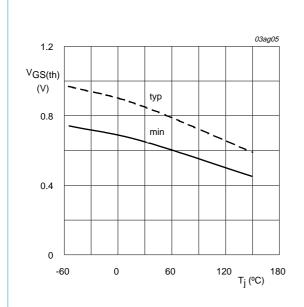
Fig 6. Transfer characteristics: drain current as a function of gate-source voltage; typical values.



 $a = \frac{R_{DSon}}{R_{DSon(25^{\circ}C)}}$

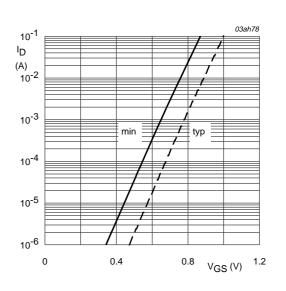
Fig 8. Normalized drain-source on-state resistance factor as a function of junction temperature.

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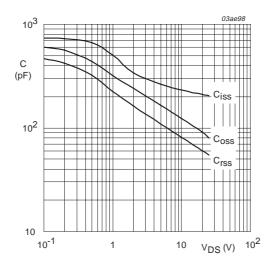
 $I_D = 1 \text{ mA}; V_{DS} = V_{GS}$

Fig 9. Gate-source threshold voltage as a function of junction temperature.



 $T_{j} = 25 \, ^{\circ}C; \, V_{DS} = 5 \, V$

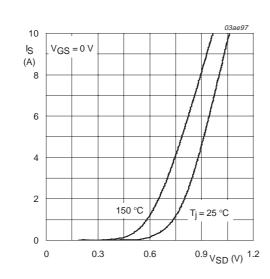
Fig 10. Sub-threshold drain current as a function of gate-source voltage.



 $V_{GS} = 0 V$; f = 1 MHz

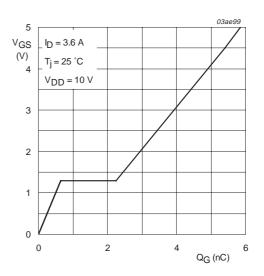
Fig 11. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values.

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 T_i = 25 °C and 150 °C; V_{GS} = 0 V

Fig 12. Source (diode forward) current as a function of source-drain (diode forward) voltage; typical values.



 $I_D = 3.6 \text{ A}; V_{DD} = 10 \text{ V}$

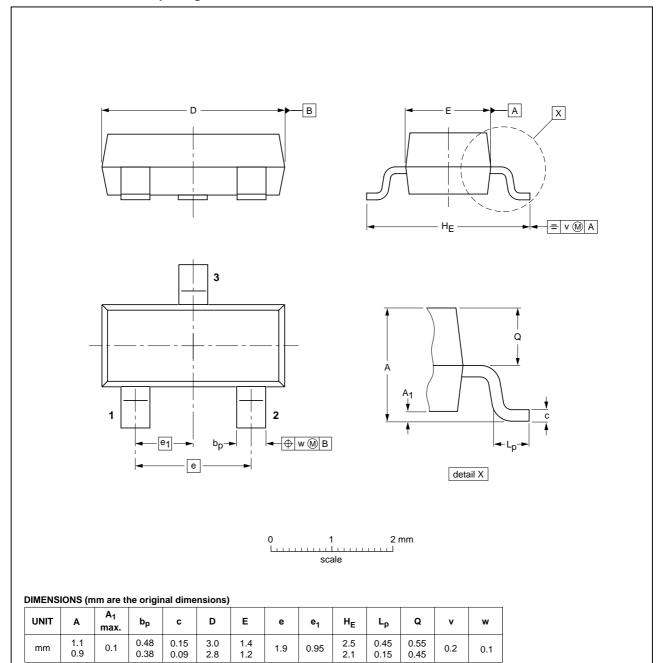
Fig 13. Gate-source voltage as a function of gate charge; typical values.

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7. Package outline

Plastic surface mounted package; 3 leads

SOT23



OUTLINE		REFER	RENCES	EUROPEAN	ISSUE DATE	
VERSION	IEC	JEDEC	EIAJ	PROJECTION	ISSUE DATE	
SOT23		TO-236AB			97-02-28 99-09-13	

Fig 14. SOT23.

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8. Revision history

Table 6: Revision history

Rev	Date	CPCN	Description
02	20040624	-	Product data (9397 750 13495)
			Modifications:
			 Updated to latest standards.
			 Section 1.4 "Quick reference data" I_D and P_{tot} increased.
			 Section 4 "Limiting values" I_D, I_{DM}, P_{tot} and I_S increased.
			 Section 4 "Limiting values" Figure 3 modified.
			 Section 5 "Thermal characteristics" Figure 4 modified.
01	20030226	-	Product data (9397 750 11096).

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Fax: +31 40 27 24825

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Contents

1	Product profile
1.1	Description
1.2	Features
1.3	Applications 1
1.4	Quick reference data 1
2	Pinning information 1
3	Ordering information
4	Limiting values 2
5	Thermal characteristics 4
5.1	Transient thermal impedance 4
6	Characteristics 5
7	Package outline 9
8	Revision history
9	Data sheet status
10	Definitions
11	Disclaimers 11
12	Trademarks 11

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